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# A holistic approach to interface stabilization for efficient perovskite solar modules with over 2000 hour operation stability

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Upscaling of perovskite solar cells to module scale and affording long-term 17 18 stability have been recognized as the most important challenges for commercialization 19 of this emerging photovoltaic technology. In a perovskite solar module (PSM), each 20 interface within the device contributes to the efficiency and stability. Here, we employ 21 a holistic interface stabilization strategy by modifying all the relevant layers and 22 interfaces, namely the perovskite layer, charge transporting layers and the device encapsulation to improve the efficiency and stability of PSMs. The treatments were 23 24 selected to be compatible with low-temperature scalable processing and the module 25 scribing steps. Our unencapsulated PSM achieved a reverse-scan efficiency of 16.6% with a designated area of 22.4 cm<sup>2</sup>. The encapsulated PSM retained approximately 86% 26

of the initial performance after continuous operation for 2000 h under AM 1.5G light illumination, with translates into a  $T_{90}$  lifetime of 1570 h and an estimated  $T_{80}$  lifetime of 2680 h.

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## 31 Introduction

In the past decade, small-size perovskite solar cells (PSCs) with an active area of 32  $\sim 0.1 \text{ cm}^2$  have achieved outstanding power conversion efficiencies (PCE) over 25%.<sup>1</sup> 33 For practical applications, PSCs must retain high efficiency when up-scaled. However, 34 when their size was increased to module scale with active area above 10 cm<sup>2</sup> the 35 efficiency decreased significantly. The efficiency of 10-cm<sup>2</sup> perovskite solar modules 36 (PSMs) is currently in the range of  $10 \sim 17\%$ .<sup>2-4</sup> As the PCE is still much lower than 37 that of commercialized solar modules based on other photovoltaic technologies it is 38 desirable to further improve the PSMs efficiency. 39

Besides up-scalability and efficiency, the long-term stability of PSMs is another 40 important aspect for their practical application.<sup>5,6</sup> In particular, the device operation 41 stability under continuous illumination is an important indicator of the long-term 42 stability of PSCs, as well as PSMs.<sup>5,7-9</sup> To improve the continuous operation stability 43 of PSCs, the engineering of the individual functional layer and the relevant interfaces 44 including perovskite layer<sup>10-14</sup>, electron transport layer (ETL)<sup>15</sup>, hole transport layer 45 (HTL)<sup>16</sup>, counter electrode (CE)<sup>17</sup> and encapsulation layer<sup>18</sup> has been developed in 46 separate works. Although fine control of each interface has been proven to be of chief 47 importance for the photovoltaic performance of PSCs, similar interface engineering 48 strategies have not been widely considered and systematically investigated in the 49 context of PSMs. This has been proposed to be the main reason why the PSCs stability 50 reduce quickly when scaling up.<sup>2,4</sup> It is thus desirable to transfer the accumulated 51 successful experiences in PSCs to PSMs. 52

53 Since each functional layer in a PSM contributes to its efficiency and stability, a 54 holistic approach to the optimization of the interfaces of each functional layer 55 throughout the entire device must be employed rather than the engineering of an

individual interface. However, the structure of PSMs is complex compared to 56 57 small-area cells due to the series connections of multiple sub-cells and P1-P2-P3 58 interconnection structures. The interface engineering strategies employed in lab-scale PSCs that work for small-area cell are not always trivial to transfer to PSMs. For 59 example, TiO<sub>2</sub> ETL has played a pivotal role in high-efficiency PSCs, but if one does 60 not remove TiO<sub>2</sub> in the P2 patterning step for PSM, the relatively high resistance of 61 TiO<sub>2</sub> will cause a substantially lower FF.<sup>19,20</sup> Besides, the exposure of P2 and P3 62 patterning lines also increase the possibility for external stressor induced degradation.<sup>21</sup> 63 Therefore, a holistic approach to PSM design that considers the process compatibility 64 with scalable production as well as the module structure and encapsulation is essential 65 66 for transferring the strategies of PSCs to PSMs.

Here, we report a holistic interface stabilization (HIS) strategy that takes into 67 consideration the engineering of all the relevant interfaces in a perovskite solar device 68 at the module scale. More specifically, we stabilize the  $SnO_2$  ETL with 69 ethylenediaminetetraacetic acid dipotassium (EDTAK), reduce the defects in the 70 perovskite surface with an ethylammonium iodide (EAI) treatment, inhibit the 71 72 moisture ingress Au migration into the and 2,2',7,7'-tetrakis[N,N-bis(p-methoxyphenyl)amino]-9,9'-spirobifluorene 73

(spiro-OMeTAD) HTL with the incorporation of poly(3-hexylthiophene) (P3HT) and 74 ensure an effective device encapsulation with a parylene film. These treatments are 75 not only compatible with scalable processing but also with scribing steps. Our HIS 76 strategy leads to not only PSMs efficiency improvement, but also stability 77 enhancement. The PSMs without encapsulation achieved a reverse-scan efficiency of 78 16.6% with a designated area of 22.4 cm<sup>2</sup>. The encapsulated PSM with the best 79 stability gave T<sub>90</sub> and T<sub>80</sub> operation stability lifetime of 1570 h and 2680 h, 80 81 respectively, under AM 1.5G light illumination test.

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#### 83 Holistic interface stabilization approach

We adopt an indium tin oxide (ITO)/SnO<sub>2</sub>/Cs<sub>0.05</sub>FA<sub>0.54</sub>MA<sub>0.41</sub>Pb( $I_{0.98}Br_{0.02}$ )<sub>3</sub> (FA is 84 formamidinium, MA is methylammonium)/spiro-OMeTAD/Au configuration as the 85 basis to fabricate PSMs.<sup>22,23</sup> To improve both efficiency and stability, we devise an 86 HIS strategy that optimize all the relevant layers and interfaces from the bottom ETL 87 layer to the top encapsulation layer as shown in Figure 1. We consider the 88 compatibility of each individual interface modification with the other modifications, 89 with the PSM design and with the scalable manufacturing. Such integrated approach 90 should facilitate the future transfer of the optimized device design to practical 91 manufacturing processes. 92



**Figure 1 Holistic interface stabilization (HIS) strategy for PSMs**. The HIS strategy consists of four treatments for the main device layers and their interfaces: the use of EDTAK to modify SnO<sub>2</sub>; the use of EAI/MAI to form the EAMA-based perovskite on the surface of Cs<sub>0.05</sub>FA<sub>0.54</sub>MA<sub>0.41</sub>Pb(I<sub>0.98</sub>Br<sub>0.02</sub>)<sub>3</sub> (FAMA based perovskite); the incorporation of P3HT into the spiro-OMeTAD layer; the employment of the parylene encapsulation.

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101 Regarding ETL and ETL/perovskite interface, we employ a commercial  $SnO_2$  as 102 ETL to take advantage of its efficient electron-selective properties<sup>24</sup>, and its 103 compatibility with low-temperature and scalable coating  $process^{22}$ . The use of 104 approximately 20 nm-thick  $SnO_2$  layer also enables a low resistance of P2 105 interconnection to ensure low series resistance and high fill factor.<sup>19,25</sup> Furthermore, we 106 use EDTAK to mitigate the reaction of OH<sup>-</sup> in SnO<sub>2</sub> with perovskite and tune the 107 energy-level alignment at the ETL/perovskite interface. This modification also has 108 negligible influence on the conductivity of the SnO<sub>2</sub> layer, which is important to ensure 109 high-quality interconnection with low series resistance between each sub-cell in PSMs.

110 Regarding the perovskite/HTL interface, we use EAI/MAI surface treatment to 111 passivate the surface defects of  $Cs_{0.05}FA_{0.54}MA_{0.41}Pb(I_{0.98}Br_{0.02})_3$  perovskite (PVSK) 112 and tune the energy-level alignment at this interface. The formed EAMA-perovskite 113 could also reduce the influences from moisture in both top surface region and the 114 regions related to wiring and encapsulation.

We then incorporate P3HT into the spiro-OMeTAD layer to induce a stable HTL against moisture and Au migration during device operation and P2 cutting process.<sup>21</sup>

117 These steps, the coating of  $SnO_2$  with EDTAK followed by the deposition of the 118 perovskite layer and the subsequent EAI/MAI treatment as well as the deposition of the 119 HTL are highly compatible with scalable coating processes developed for organic and 120 dye-sensitized solar modules.<sup>2,4</sup>

On the top of metal electrode, parylene encapsulation was made via upscalable chemical vapor deposition. Parylene encapsulation acts as a uniform and robust barrier layer, which helps keep the whole module including the P2 and P3 patterning lines into a closed space to prevent diffusion of external ambient gases such as moisture and oxygen, and contain the internally generated volatile degradation products.<sup>26</sup>

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#### 127 Stabilization of the ETL/perovskite interface

A stable ETL/perovskite contact and suitable energy-level alignment at this interface is essential for efficient and stable PSCs. The first step of our HIS strategy is to mitigate the reaction of  $OH^-$  in  $SnO_2$  with perovskite (Supplementary Figure 1 and Supplementary Note 1) to form a stable ETL/perovskite interface by using EDTAK to post-treat the SnO<sub>2</sub> layer on the basis of the acid-base neutralization reaction. The use of EDTAK also retained the positive passivation effect of  $K^{+,22}$  The treatment condition was optimized by changing the EDTAK concentration (Supplementary Table 1).

The observed N 1*s* peak in X-ray photoelectron spectroscopy (XPS) results in Figure 2a confirms the existence of EDTAK on the surface of the EDTAK treated SnO<sub>2</sub> (SnO<sub>2</sub>-EDTAK) films. By immersing the SnO<sub>2</sub>-EDTAK sample and pristine sample (SnO<sub>2</sub>) into water and testing the pH value of the obtained aqueous solution, the pH value is slightly alkaline for the control sample, and neutral for the SnO<sub>2</sub>-EDTAK sample. Based on the above observation, the reaction of KOH with perovskite is believed to be effectively mitigated by the EDTAK treatment.



Figure 2 ETL/perovskite and perovskite/HTL interface stabilization and energy-level alignment. a-b, The N 1s spectra (a) and Sn 3d spectra (b) of SnO<sub>2</sub> and SnO<sub>2</sub>-EDTAK films measured by XPS measurements. In (a) and (b), black circles show the original XPS data, black curves represent the background, the grey bold curves show the total fitting results. In (a), the purple vertical dash line shows the N 1s position with respect to SnO<sub>2</sub>-EDTAK, the purple curves are the fitting results of

N1s signal. In (b), the red and blue vertical dash line show the Sn  $3d_{3/2}$  and Sn  $3d_{5/2}$ 150 position, respectively, with respect to pristine SnO<sub>2</sub>, the red and blue curves are the 151 fitting results of Sn  $3d_{3/2}$  and Sn  $3d_{5/2}$  signal, respectively. c, UPS spectra (using the 152 153 He-I line with a photon energy of 21.22 eV) corresponding to the secondary electron 154 onset region and valence band maximum (VBM) of SnO<sub>2</sub>, SnO<sub>2</sub>-EDTAK, perovskite (PVSK), EAI/MAI-treated perovskite (PVSK(EAMA)) with respect to the Fermi 155 156 energy (E<sub>F</sub>). VBM for perovskites was determined from the semi-log plots (Supplementary Figure 3). d, Diagram of the energy levels of the materials as 157 extracted from the UPS data. 158

Unlike a previous study<sup>27</sup> using EDTA as a pretreatment modifier to modify the 159  $SnO_2$  colloidal solution, in the current work EDTAK is used as an interface 160 post-treatment modifier to tune the energy-level alignment at the ETL/perovskite 161 interface.<sup>28</sup> To investigate this point, XPS and ultraviolet photoemission spectroscopy 162 163 (UPS) measurements were conducted. The observed slight shift of the Sn 3d peaks of 164  $SnO_2$ -EDTAK with respect to  $SnO_2$  (Figure 2b) suggests a chemical interaction of EDTAK with SnO<sub>2</sub>, which is likely to affect the energy-level alignment at the 165 ETL/perovskite interface. As shown in Figure 2c, the work function (WF) of pristine 166 167 SnO<sub>2</sub> and SnO<sub>2</sub>-EDTAK is determined to be 3.84 eV and 4.00 eV, respectively. On the basis of our UPS and XPS analysis, EDTAK most likely act as interface modifier 168 leading to variations in the WF of SnO<sub>2</sub>-EDTAK, while minimum changes are 169 170 observed for VBM and XPS Sn 3d core levels (see Supplementary Figure 2 and 171 Supplementary Note 2).

The conduction band minimum (CBM) of the pristine  $SnO_2$  was calculated to be -3.69 eV (with respect to the vacuum level  $E_{vac}$ ), in agreement with reported values.<sup>24,25</sup> The CBM of  $SnO_2$ -EDTAK film shifts downward by about 0.26 eV with respect to the pristine  $SnO_2$  film, which was calculated to be -3.95 eV. The improved energy-level alignment with CBM (-3.93 eV) of the perovskite (Figure 2d and Supplementary Figure 3) is expected to be beneficial for charge extraction at perovskite/ ETL interface.

To verify this, time resolved photoluminescence (TRPL) measurements were conducted (Supplementary Figure 4). The faster quench of perovskite PL for 181 SnO<sub>2</sub>-EDTAK versus SnO<sub>2</sub> indicates a faster charge transfer from perovskite to
182 SnO<sub>2</sub>-EDTAK.

We also used secondary ion mass spectrometry (SIMS) measurements to investigate whether  $K^+$  in EDTAK-SnO<sub>2</sub> can migrate into the perovskite film (Supplementary Figure 5). The SIMS result confirms that the  $K^+$  is distributed in both perovskite bulk film and in the EDTAK-SnO<sub>2</sub> film. The  $K^+$  <sup>22,29</sup> and Lewis base of the alkylamine group<sup>30</sup> in EDTAK-SnO<sub>2</sub> could passivate perovskite defects, which is supported by the longer PL lifetime of the glass/EDTAK/perovskite sample versus the glass/perovskite sample (Supplementary Figure 4 and Supplementary Table 2).

190 To study the effect of the EDTAK treatment on device performance, small-size PSCs were fabricated (Supplementary Figure 6). The current density-voltage (J-V) 191 curves of the devices based on pristine SnO<sub>2</sub> and EDTAK-SnO<sub>2</sub> are shown in Figure 192 3a. The pristine SnO<sub>2</sub> based PSCs (denoted as SnO<sub>2</sub>/PVSK/spiro-OMeTAD/Au) show 193 a typical PCE of 19.2% with a short-circuit current density ( $J_{SC}$ ) of 23.2 mA cm<sup>-2</sup>, an 194 open-circuit voltage ( $V_{OC}$ ) of 1.07 V, and a fill factor (FF) of 77.6%. EDTAK-SnO<sub>2</sub> 195 based PSCs show a  $J_{SC}$  of 23.2 mA cm<sup>-2</sup> a  $V_{OC}$  of 1.10 V and a FF of 78.4%, leading 196 197 to an improved PCE of 20.1% with suppressed hysteresis (Supplementary Table 3). As 198 shown in Figure 3b, the representative external quantum efficiency (EQE) of 199  $SnO_2$ -EDTAK device shows slightly higher values than the  $SnO_2$  device at both the short-wavelength and long-wavelength region, leading to a slightly higher integrated 200 Jsc for the former case (22.8 mA  $\text{cm}^{-2}$  versus 22.4 mA  $\text{cm}^{-2}$ ). The improved Jsc as 201 well as improved  $V_{OC}$  and FF are likely due to dual function of the EDTAK treatment, 202 i.e., improvement of charge transport and suppression of charge recombination as 203 204 discussed above.

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#### Stabilization of the perovskite/HTL interface

The second interface stabilization step is focused on the perovskite/HTL interface. The higher defect density at the perovskite surface, especially at the surface grain boundaries, with respect to the perovskite/ETL interface usually affects device performance and stability significantly.<sup>14,31</sup> Here, interface stabilization with EAI/MAI modification is adopted on the surface of perovskite to passivate defects as well as to enhance the device stability due to the robust stability of the EAMA based perovskite<sup>32-34</sup>. With respect to long-alkyl or other large-size ammonium-based cations, EA<sup>+</sup> has a relative smaller size, which favors the formation of quasi-3D perovskite even with a relative high EA content (Supplementary Note 3, Supplementary Figure 7-9 and Supplementary Table 4).<sup>35-37</sup>

To check the effect of the EAI/MAI treatment on the device performance 216 217 (Supplementary Figure 10), small-size PSCs were fabricated, a typical J-V curve is shown in Figure 3a. The devices with both EDTAK and EAI/MAI treatment (denoted 218 219 as SnO<sub>2</sub>-EDTAK/PVSK(EAMA)/spiro-OMeTAD/Au, PVSK(EAMA) is Cs<sub>0.05</sub>FA<sub>0.54</sub>MA<sub>0.41</sub>Pb(I<sub>0.98</sub>Br<sub>0.02</sub>)<sub>3</sub> perovskite with the EAI/MAI treatment) show a 220 typical PCE of 21.8% with a  $J_{SC}$  of 23.6 mA cm<sup>-2</sup>, a  $V_{OC}$  of 1.12 V, and a FF of 221 82.3%. Based on EQE result in Figure 3b, the integrated current density is calculated 222 to be 23.3 mA cm<sup>-2</sup>, which is consistent with J<sub>SC</sub> obtained from the J-V curve. This 223 is also higher of device 224 value than that the without treatment (SnO<sub>2</sub>/PVSK/spiro-OMeTAD/Au) with 225 and device EDTAK treatment 226 (SnO<sub>2</sub>-EDTAK/PVSK/spiro-OMeTAD/Au). Especially, the device with both EDTAK 227 and EAI/MAI treatment shows higher EQE values at the long-wavelength region than 228 that of device with EDTAK treatment. Considering that long-wavelength light is 229 mainly absorbed by the perovskite near the perovskite/HTL interface. The improved 230 current density is proposed attributed to the passivation effect of EAI/MAI treatment. 231 Besides, the improved FF and V<sub>OC</sub> also contribute to significantly improved PCE 232 from 20.1% to 21.8% with EAI/MAI treatment.

To verify the passivation effect of EAI/MAI treatment, we used TRPL to investigate the charge carrier properties of the perovskite with and without EAI/MAI treatment (Figure 3c and Supplementary Table 5). The EAI/MAI treated perovskite sample showed a much longer PL lifetime than that of the untreated perovskite sample (122.4 ns versus 42.8 ns), which is likely the result of a reduction in nonradiative recombination by defect passivation via the EAI/MAI treatment. The defect density reduction from  $0.86 \times 10^{16}$  to  $0.47 \times 10^{16}$  cm<sup>-3</sup> measured by space-charge-limited current (SCLC) test further confirms the passivation effect of the EAI/MAI treatment (Figure 3d and e and Supplementary Note 4).

In addition, the EAI/MAI treatment affects the energy-level alignment at the 242 perovskite/HTL interface. As shown in Figure 2c and d, the WF of EAI/MAI treated 243 perovskite and untreated perovskite is determined to be 3.99 eV and 4.34 eV, 244 respectively. The VBM is determined to be 1.41 eV and 1.17 eV, respectively, 245 yielding the ionization energy value of 5.40 eV and 5.51 eV for perovskite with and 246 without EAI/MAI treatment, respectively. The relative energy level position of the 247 248 Fermi level shift also indicates a more *n*-type nature for the top surface of perovskite 249 after the EAI/MAI treatment (Figure 2c, 2d, and Supplementary Figure 3), which is 250 likely to originate from the partial change of the lead halide rich surface to a more organic halide rich surface induced by the EAI/MAI treatment.<sup>38</sup> 251

The mismatch of the energy-level alignment between perovskite and 252 spiro-OMeTAD (ionization energy, 5.18 eV<sup>39</sup>) is reduced from 0.33 eV to 0.22 eV 253 after the EAI/MAI treatment, which may benefit charge extraction at the 254 255 perovskite/HTL interface. A faster quenching of perovskite PL for the 256 PVSK(EAMA)/spiro-OMeTAD in comparison with PVSK/spiro-OMeTAD sample 257 measured by TRPL (Figure 3c and Supplementary Table 5), further suggests that 258 faster charge transfer occurs from EAI/MAI treated perovskite to spiro-OMeTAD. 259 This also contributes to the suppressed hysteresis for the PSCs with both EDTAK and EAI/MAI treatment versus the PSCs with EDTAK treatment (Supplementary Table 260 261 3).



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Figure 3 PSCs performance with ETL/perovskite and perovskite/HTL interface 263 stabilization treatments and passivation effect of EAI/MAI treatment. a, J-V 264 curves and b, EQE spectra and integrated J<sub>SC</sub> of the PSCs treated with both EDTAK 265 and EAI/MAI (red curve), treated with EDTAK (blue curve) and without treatments 266 (black curve). c, TRPL decay curves of the perovskite thin film with (blue and black 267 268 curves) or without (pink and red curves) EAI/MAI treatment as bare film (black and red curves) or interfaced with spiro-OMeTAD (blue and pink curves). d-e, J-V 269 characteristics of SCLC result. The J-V curve can be fitted according to  $J \propto V^n$  with 270 271 different values of the exponent n: n = 1 is the ohmic region (dark fitted lines in (d) and (e)); n > 3 is the trap-filled limited (TFL) region (red fitted line and blue fitted 272 line in (d) and (e), respectively). The TFL voltage ( $V_{TFL}$ ) is onset voltage of the TFL 273 274 region.

To further explore how the EAI/MAI treatment affects the perovskite film stability, the morphology of the perovskite with and without EAI/MAI treatment is measured by scanning electron microscopy (SEM) (Figure 4a-b). The grain boundaries are filled with additional structure for the EAI/MAI treated perovskite film with reduced roughness from 27.4 to 19.7 nm confirmed by atomic force microscopy (AFM) measurements (Figure 4c-d).

It has been reported that perovskite decomposition mainly starts from grain boundaries due to the relatively weak chemical binding and severe ion migration.<sup>14,31</sup> The newly formed EAMA perovskite is thus expected to improve the perovskite stability due to passivation of grain boundaries. To verify this, the perovskite films are further subjected to high-energy electron beam with a voltage of 20 kV under SEM measurements (Supplementary Figure 11). Obvious cracks are observed for the untreated perovskite film, while the EAI/MAI treated perovskite film remains densely packed grain, which indicates an enhanced stability of latter case.<sup>30</sup>

To further study the perovskite stability, the perovskite films with and without 289 290 EAI/MAI treatment are subject to a high relative humidity close to 100% at approximately 40 °C by monitoring the XRD evolution (Figure 4e-f). The PbI<sub>2</sub> peak 291 292 in the untreated perovskite film shows much faster increase than that in the EAI/MAI 293 treated perovskite film, which indicates slower degradation of EAI/MAI treated perovskite. The 85 °C thermal aging test of the films in a dry N<sub>2</sub> glove box also 294 suggests the improved stability of EAI/MAI treated perovskite film (Supplementary 295 Figure 12). These XRD observations together with the above morphology study 296 coincidently suggest that the stability of perovskite film can be improved via 297 EAI/MAI treatment.31 298





Figure 4 Perovskite film stability with perovskite/HTL interface stabilization.
a-b Surface SEM images of the perovskite films without (PVSK) (a) and with
(PVSK(EAMA)) (b) EAI/MAI treatment. c-d, AFM topography of the perovskite
films without (c) and with (d) EAI/MAI treatment, RSM is root mean squared surface

roughness. e-f, XRD patterns evolution of the perovskite films without (e) and with
(f) EAI/MAI treatment under aging test in a high relative humidity close to 100%
condition at approximately 40 °C.

To apply the above studied interface stabilization strategy into large-scale device, PSMs were fabricated based on mirror-like and uniform large-area perovskite films (Supplementary Figure 13). Figure 5a shows the optical image of the PSM and Figure 5b shows the J-V curves of the PSMs with a designated area of 22.4 cm<sup>2</sup> obtained from reverse scan.

Consistent with the PSCs performance, the PSM with both EDTAK and 312 EAI/MAI treatment (SnO<sub>2</sub>-EDTAK/PVSK(EAMA)/spiro-OMeTAD/Au) showed 313 314 substantially better performance (Supplementary Table 6). A champion module with 315 both EDTAK and EAI/MAI treatment show a reverse-scan PCE of 16.6%, which corresponds to an active-area-efficiency of 18.2% (Supplementary Figure 14). To 316 confirm our J-V results, we sent our module to National Institute of Advanced 317 Industrial Science and Technology (AIST) for J-V characterization according to their 318 standard protocol IEC60904-3 Ed. 3 (Supplementary Figure 15). The result is 319 relatively consistent with our in-house measurements (Supplementary Figure 16). 320

The PSMs with both EDTAK and EAI/MAI treatment also exhibit good 321 322 reproducibility (Supplementary Figure 17, Supplementary Table 7) and a small 323 hysteresis (Supplementary Figure 18). To study the operation stability of above PSMs without encapsulation, we tracked the operation stability at a fixed bias that was set to 324 be the initial MPP voltage under continuous AM 1.5G light illumination in a N<sub>2</sub> box 325 with a relative humidity <5% (Figure 5c). The initial values of the PV parameters for 326 the devices tested for stability are reported in Supplementary Table 6. It was found 327 that the T<sub>80</sub> lifetime of the PSMs is estimated to be 24, 116 and 268 h, respectively. 328 329 The significantly improved device stability for the modules with both EDTAK and 330 EAI/MAI treatment is ascribed to the above-mentioned ETL/perovskite and 331 perovskite/HTL interface stabilization strategy.

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## 333 Stabilization of the HTL/electrode interface

A stable HTL/electrode interface is also important for PSM stability.<sup>41</sup> To further 334 improve the stability of HTL, we incorporated a small amount of P3HT into 335 spiro-OMeTAD.<sup>42</sup> This mixed HTL (denoted as spiro-OMeTAD-P3HT) can deliver 336 comparable performance with the spiro-OMeTAD based PSM (Supplementary Figure 337 19 and 20, Supplementary Table 6). To study whether this strategy can improve the 338 stability, we measured the operation stability of PSM based on mixed HTL 339 (SnO<sub>2</sub>-EDTAK/PVSK(EAMA)/spiro-OMeTAD-P3HT/Au). It was found that the 340 module with both EDTAK and EAI/MAI treatment and mixed HTL shows a  $T_{80}$ 341 lifetime exceeding 1600 h, which is much longer than the pure spiro-OMeTAD case 342 343 (Figure 5c). We ascribe the improved stability to the HTL/CE interface engineering, where the spiro-OMeTAD-P3HT layer may slow down the gold inward migration and 344 345 also enhance the stability of HTL against moisture. To verify this, we performed SIMS measurements on the aged samples (Supplementary Figure 21). The SIMS 346 results coherently indicate that the slower Au migration into spiro-OMeTAD-P3HT 347 versus spiro-OMeTAD case, which slow down the irreversible degradation induced by 348 Au migration.<sup>40</sup> The improved shielding effect of the spiro-OMeTAD-P3HT is 349 350 assigned to the thiophene-like structures of P3HT that has a strong chemical 351 interaction with Au, which helps retard Au migration (Supplementary Figure 22 and 352 Supplementary Note 5).

In addition, moisture resistance of the HTLs was studied by measuring the 353 contact angle of a deionized water droplet. The contact angle is increased from 71.6° 354 for the spiro-OMeTAD sample to 107.0° for the spiro-OMeTAD-P3HT sample 355 (Supplementary Figure 23). This observation evidently demonstrates a change of HTL 356 357 from hydrophilic to hydrophobic through introducing additional conjugated polymers, 358 i.e., P3HT into spiro-OMeTAD. The improved moisture resistance is beneficial for the 359 device resistance against moisture during P2 cutting process and device operation. Note that when water droplets were kept on the top of spiro-OMeTAD-P3HT layer for 360 361 several minutes during the contact angle test, the underneath perovskite still changed 362 its color from dark brown to yellow, which suggests the spiro-OMeTAD-P3HT is not

able to completely retard the moisture induced degradation. This observation inspired

364 us to make additional interface stabilization to further improve the PSMs stability.

365

#### 366 **Device encapsulation**

To further improve PSMs stability, parylene encapsulation<sup>43</sup> and cover glass protection are employed on PSMs with both EDTAK and EAI/MAI treatment and mixed HTL (Supplementary Figure 24-26). The encapsulated PSMs show a comparable efficiency as PSMs without encapsulation (Supplementary Figure 27).

The operation stability of three encapsulated PSMs was investigated (Figure 5d 371 372 and Supplementary Figure 28), and the temperature on the surface of the module was measured to be approximately 40 °C during stability measurements (Supplementary 373 374 Figure 29). All three modules show nearly identical stability evolution trend. At the 375 beginning, there is a very fast burn-in decay process. This might due to the thermal 376 effect, a faster perovskite degradation or spiro-OMeTAD conductivity variation (Supplementary Note 6). We then observed a slightly increase of the performance 377 378 followed by a slow linear decay, where the slow increase after burn-in decay is likely 379 due to the perovskite recovery or spiro-OMeTAD conductivity recovery 380 (Supplementary Note 6). Figure 5d shows that the encapsulated PSM with the best stability remained 86% of the initial performance after aging for 2000 h, and gave a 381  $T_{90}$  lifetime of 1570 h and an estimated  $T_{80}$  lifetime of 2680 h.<sup>31</sup> Moreover, all three 382 modules show a T<sub>80</sub> lifetime over 2000 h with good stability reproducibility, which 383 give an average T<sub>80</sub> lifetime of 2457±274 h. 384

Here, the parylene encapsulation is demonstrated to act as a thin-film barrier largely to enhance the long-term stability of PSMs (Supplementary Note 7). The thermal stability (60 °C) of the PSMs was also studied. The PSMs retained over 80% of their initial efficiency after 1000 h test (Supplementary Figure 30 and Supplementary Table 8). When compared with the reported results, our modules performance result is among the top reported efficiency and stability for PSMs (Supplementary Table 9). Our PSMs stability study suggests the relatively good stability of our solar module and verify the effectiveness of above studied HISstrategy.



394

Figure 5 PSMs photovoltaic performance and stability. a, Photograph of a 395 PSM. **b**, Representative J–V curves of the PSMs with varying structures. **c**, Operation 396 stability of un-encapsulated PSMs with varying structures measured at a fixed bias 397 near initial maximum power point (MPP) under continuous AM 1.5G light 398 illumination in a  $N_2$  box with a relative humidity <5%. The initial values of the PV 399 400 parameters for the devices tested for stability are reported in Supplementary Table 6. 401 d, Operation stability of encapsulated SnO<sub>2</sub>-EDTAK/PVSK(EAMA)/spiro-OMeTAD-P3HT/Au PSM with parylene and a 402 403 cover glass measured under the same conditions as in (b). The initial values of the PV parameters for the PSM tested for stability are reported in Supplementary Figure 27, 404 PSM #1. 405

406

#### 407 **Conclusions**

In summary, we demonstrated a holistic interface engineering strategy to 408 409 fabricated PSMs relying on treatments that are compatible with scalable processing 410 and scribing steps. First, we treated the  $SnO_2$  ETL with EDTAK to mitigate the reaction of OH<sup>-</sup> with perovskite, passivate defects and afford good energy-level 411 412 alignment at the ETL/perovskite interface. Then, we passivated surface defects at the 413 perovskite/HTL surface with ethylammonium iodide as well as improved perovskite 414 stability and energy-level alignment at the perovskite/HTL interface. We then 415 improved the device stability by incorporating P3HT into the HTL and encapsulate the device with a parylene film. The resultant PSMs without encapsulation achieved a 416 reverse-scan efficiency of 16.6% with a designated area 22.4 cm<sup>2</sup>. Moreover, the 417 encapsulated PSM stability maintained about 86% of the initial performance after 418 419 continuous operation for 2000 h under AM 1.5G light illumination, which translates into a  $T_{90}$  lifetime of 1570 h and a  $T_{80}$  lifetime of 2680 h. This demonstration is a step 420 421 forwards in the development and commercialization of large-scale perovskite 422 photovoltaics.

423

#### 424 Methods

425 Materials. All reagents were used as received without further purification, including PbI<sub>2</sub> (99.99%, TCI), formamidinium iodide (FAI, greatcell solar), 426 427 methylammonium iodide (MAI, greatcell solar), methylammonium bromide (MABr, greatcell solar), methylammonium chloride (MACl, greatcell solar), ethylammonium 428 iodide (EAI, Sigma-Aldrich), cesium iodide (Sigma-Aldrich), 4-tert-butylpyridine 429 430 (99.9%, Sigma Aldrich), bis(trifluoromethane)sulfonimide lithium salt (Li-TFSI, Sigma-Aldrich), acetonitrile (99.9%, Sigma-Aldrich), chlorobenzene (99.8%, Wako), 431 432 2,2',7,7'-tetrakis(N,N-di-p-methoxyphenylamine)-9,9'-spirobifluorene

(spiro-OMeTAD, Merck), poly(3-hexylthiophene) (P3HT, Luminescence Technology
Corp.), SnO<sub>2</sub> (Alfa Aesar, tin (IV) oxide, 15% in H<sub>2</sub>O colloidal dispersion),
ethylenediaminetetraacetic acid dipotassium (Sigma-Aldrich), methanol (Wako),

isopropanol (Wako), N,N-dimethylformamide (DMF, Wako), dimethyl sulfoxide(DMSO, Wako).

438 **PSCs fabrication.** The ITO substrate was sequentially washed with distilled water, acetone, ethanol and isopropanol. Then treated using  $UV/O_3$  for 30 min. The 439 SnO<sub>2</sub> layer was subsequently coated on ITO substrate with the SnO<sub>2</sub> nanocrystal 440 solution (diluted by H<sub>2</sub>O to 2.5%) at 3000 rpm for 30 s, and annealed at 150 °C for 30 441 min in air. Then an ethylenediaminetetraacetic acid dipotassium methanol solution 442 was spin-coated on the SnO<sub>2</sub> film at 3000 rpm for 30 s, and annealed at 100 °C for 5 443 min in air. Then, a 1.35 M PbI2 and 0.0675 M CsI solution (dissolved in mixed 444 DMF/DMSO (V:V = 19:1) solvent and stirred at 70  $^{\circ}$ C for 2 hours before filtered with 445 PTFE syringe filters) was spin-coated on substrate at 2000 rpm for 30 s. Then a mixed 446 organic cation solution (FAI 400 mg; MAI 200 mg; MABr 50 mg; MACl 50 mg, 447 448 dissolved in 10 mL isopropanol) was spin-coated at 1750 rpm. for 30 s and then 449 annealed at 150 °C for 15 min in air. Then a EAI/MAI solution dissolved in mixed IPA/DMF (V:V = 200:1) was spin-coated on the top of perovskite layer at 6000 rpm 450 for 30 s and annealed at 70 °C for 5 min. Then the hole transport materials (HTM) 451 452 solution was deposited by spin-coating at 3000 rpm for 30 s. The spiro-OMeTAD 453 solution was prepared by dissolving spiro-OMeTAD in chlorobenzene (72.3 mg mL<sup>-1</sup>) with the addition of 17.5  $\mu$ L Li-TFSI/acetonitrile (520 mg mL<sup>-1</sup>), and 28.8  $\mu$ L 454 4-tert-butylpyridine. A mixture of spiro-OMeTAD/P3HT (weight ratio, 9:1) was used 455 for mixed HTM solution preparation, similar amount of Li-TFSI and 456 4-tert-butylpyridine were added. Finally, a gold layer with a thickness of 100 nm was 457 deposited as the counter electrode on the top of HTL through shadow masks via 458 thermal evaporation under high vacuum (5  $\times$  10<sup>-5</sup> Torr). 459

**PSMs fabrication.** The perovskite solar module consists of seven perovskite sub-cells connected in series on a 5 cm  $\times$  5 cm substrate. Between each cell there is a line (P1) with a width of 50  $\mu$ m patterned by laser-etching to separate ITO stripes, with a dimension of 6.65 mm by 49 mm (Supplementary Figure 14). The ETL, perovskite, and HTL were prepared using the same process as small-size PSCs. After

coating ETL, perovskite, and HTL, one more line (P2) with a width of about 250  $\mu$ m is patterned by CO<sub>2</sub> laser with a power of 5.6 W to expose the bottom ITO/SnO<sub>2</sub> electrodes to form the series connections between the cells. A gold film with a thickness of 120 nm was then thermally evaporated as the counter electrode and each sub-cell was separated by mechanical scribing to form P3 patterning.

PSMs encapsulation. Parylene is used due to its robust water resistance 470 471 capability and the capability to provide compact enclosure to prevent leakage. In 472 addition, parylene encapsulation avoids the direct exposure of perovskite and HTL to air at the scribed series interconnections region in a PSM, which favors the 473 474 enhancement of PSM stability. Before parylene encapsulation, metal wires were 475 connected to the PSM by ultrasonic soldering (Sunbonder USM-560). Then, the 476 parylene film was deposited by a chemical vapor deposition process using PDS 2010 477 LABCOATER (Supplementary Figure 24). The PSMs for encapsulation were first 478 loaded into the CVD chamber, which was pumped to a pressure below 1500 Pa. Then, 479 the precursor particles (Parylene C, SCS coatings, 2 g) were kept at a temperature of 175 °C for vaporization. The furnace tube is kept at a temperature of 690 °C to 480 481 pyrolyse the precursor into monomers. During the parylene deposition, the chamber is 482 kept at a pressure of approximately 3500 Pa. The substrate temperature during deposition was approximately 40 °C. The polymerization and deposition rate of 483 parylene is approximately 2 µm per hour. The thickness of the parylene encapsulation 484 was approximately  $2 \mu m$ . A cover glass was further attached on the top of the PSMs to 485 provide mechanical protection for the underneath layers. For cover glass sealing, a 486 487 glass sheet with a thickness of 2 mm was carefully sealed on top of the parylene film by kapton tape (Supplementary Figure 25). The space between glass and the parylene 488 489 film is approximately 0.2 mm, which is determined by the tape thickness.

490 **Photovoltaic characterization**. J–V characteristics of perovskite solar cells are 491 measured under one sun illumination (AM 1.5 G, 100 mW cm<sup>-2</sup>, calibrated using a 492 KG3 reference Si-cell (Enlitech), Oriel Instruments Model Number 90026564,  $2\times 2$ 493 cm<sup>2</sup>) using a solar simulator (Newport Oriel Sol 1A, Xenon-lamp, USHIO,

UXL-150SO) and a Keithley 2420 source meter in ambient air at about 25 °C and a 494 relative humidity of  $40 \sim 60\%$ . The small-size PSCs were measured using a metal 495 mask with the aperture area of  $0.09 \text{ cm}^2$ . The designated area of 22.4 cm<sup>2</sup> for modules 496 was defined by a corresponding metal mask. The J-V scan range is from -0.1 V to 1.2 497 V for small-size PSCs and from -0.2 V to 8.5 V for modules. All the J-V curves were 498 measured under reverse scan with a scan rate of 0.25 V  $s^{-1}$  without preconditioning 499 unless otherwise specified. No preconditioning protocol was used before the 500 501 characterization. The EQE spectra of small-cells were characterized using Oriel IQE 502 200.

503 Stability testing. For continuous operation stability measurements, the PSMs were loaded in our home-designed enclosure box with dry N2 flow to maintain a 504 relative humidity below 5%. The PSMs were under continuous illumination by a solar 505 506 simulator (Peccell PEC-L01, AM1.5G without UV filter) and source meter (Keithley 507 2401), which was controlled by a LabView program to allow automatic measurements on the PSMs. To simulate continuous PSM operation (i.e., operation stability), a fixed 508 509 bias voltage was continuously applied to the PSMs maintaining the PSM operation 510 near the MPP. The bias voltage value was set to be the initial MPP voltage during the 511 operation stability measurement. The photocurrent output of the modules was also 512 measured by Keithley 2401, and was recorded by the home-made LabView program. For the thermal stress test under dry N<sub>2</sub> condition, the PSMs were loaded on a hotplate 513 at a temperature of approximately 60 °C for aging in a dry N<sub>2</sub> glove box with a 514 515 relative humidity below 5%.

**Characterization.** SEM measurements were carried out using a scanning electron microscope (Helios NanoLab G3 UC, FEI). XRD measurements were carried out in a Bruker D8 Discover instrument (Bruker AXS GmbH, Karlsruhe, Germany) equipped with Cu wavelength  $\lambda = 1.54$  Å X-ray source operated at 1600 W and Goebel mirror. The UPS and XPS spectra were recorded from an X-ray photoelectron spectrometer (XPS-AXIS UltranHAS, Kratos) equipped with monochromatic Al-K $\alpha$ = 1486.6 eV and nonmonochromatic He–I = 21.22 eV sources. XPS results were

functions after background subtraction 523 fitted using Gaussian-Lorentzian 524 corresponding to the inelastic scattering processes. TRPL data were acquired using the time-correlated, single-photon counting technique (Hamamatsu, C10627), and 525 excitation was provided by a femtosecond mode-locked Ti:sapphire laser 526 (Spectra-Physics, MAITAI XF-IMW) at 450 nm with an average power at 8 MHz of 527 528 0.74 mW. SIMS (Kratos Axis ULTRA) equipped with quadrupole mass spectrometer (HAL 7, Hiden Analytical) was used to collect the elemental signal in positive ion 529 detection mode (PID). For sputtering in SIMS, 3 keV  $Ar^+$  primary beam with a current 530 of 10 mA and a diameter of 100 µm was utilized. To study the effect of mixed HTM 531 532 on retarding gold migration, we have prepared the samples according to a previous study on a similar topic.<sup>40</sup> Our result was obtained from the samples with Au layer. 533 The samples were prepared on 1.5 cm  $\times$  1.5 cm ITO substrate according to the same 534 procedure as the fabrication procedure of our devices. Then, the samples were placed 535 on a hot plate which was kept at a temperature of 70 °C for 24 h in a N<sub>2</sub> glove box. 536 The aged samples were transferred into the SIMS chamber for measurements. The 537 beam was at an angle of 45 ° with respect to the sample surface normal. The 538 spectrometer was operated at a pressure of  $10^{-8}$  torr. The SCLC data were collected 539 with a semiconductor characterization system in  $N_2$  (4200-SCS, Keithley). 540 Absorbance was measured using a UV-Vis spectrometer (JASCO Inc., V-670). 541

542 **Reporting summary.** Further information on research design is available in the
543 Nature Research Reporting Summary linked to this article.

### 544 Data availability

All data generated or analysed during this study are included in the published article and its Supplementary Information. The data that support the plots within this article and other findings of this study are available from the corresponding author upon reasonable request.

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558

#### **Author contributions**

559 Y.B.Q. supervised the project. Y.B.Q. and Z.L. conceived the ideas and designed the experiments. Z.L. conducted the corresponding device fabrication and basic 560 561 characterization. Z.L. and L.Q. conducted module fabrication, encapsulation and 562 stability testing. L.Q. and L.K.O. helped with XPS, UPS and SIMS characterization 563 and analyses. S.H. helped with the module picture design and data analysis. Z.H. 564 helped with energy alignment analyses. M.J. helped with TRPL characterization. G.T., 565 Z.W., Y.J., Y.D., and S.K. provided valuable suggestions for the manuscript. S.K. contributed to the J-V characterization. Z.L. and Y.B.Q. participated in all the data 566 567 analysis. All authors contributed to writing the paper.

- 568 **Competing interests**
- All the authors declare no competing interests.
- 570 Additional information
- 571 **Supplementary information** is available for this paper at <u>https://doi.org/</u>
- 572 **Correspondence and requests** for materials should be addressed to Y.B.Q.
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